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## BIB DATA SHEET

CONFIRMATION NO. 7462

<b>SERIAL NUMBER</b> 10/530,157	<b>FILING or 371(c) DATE</b> 03/13/2006 <b>RULE</b>	<b>CLASS</b> 436	<b>GROUP ART UNIT</b> 1773	<b>ATTORNEY DOCKET NO.</b> 6317P003	
<b>APPLICANTS</b> Gilad Almogy, Kiriati-Ono, ISRAEL; Chris Talbot, Emerald Hills, AZ; Lior Levin, Cupertino, CA; <b>** CONTINUING DATA *****</b> This application is a 371 of PCT/US03/31398 10/03/2003 which claims benefit of 60/416,333 10/03/2002 <b>** FOREIGN APPLICATIONS *****</b> <b>** IF REQUIRED, FOREIGN FILING LICENSE GRANTED **</b>					
Foreign Priority claimed <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No 35 USC 119(a-d) conditions met <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No Verified and /SALLY A Acknowledged SAKELARIS/ Examiner's Signature	<input type="checkbox"/> Met after Allowance Initials	<b>STATE OR COUNTRY</b> ISRAEL	<b>SHEETS DRAWINGS</b> 15	<b>TOTAL CLAIMS</b> 44	<b>INDEPENDENT CLAIMS</b> 3
<b>ADDRESS</b> APPLIED MATERIALS, INC. c/o SNR DENTON US LLP P.O. BOX 061080 CHICAGO, IL 60606-1080 UNITED STATES					
<b>TITLE</b> System and method for defect localization on electrical test structures					
<b>FILING FEE RECEIVED</b> 1930	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit		